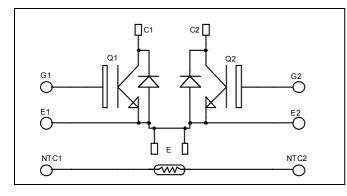


Dual common source Fast Trench + Field Stop IGBT3 Power Module



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# APTGT100DU120TG

## $V_{CES} = 1200V$ $I_{C} = 100A$ @ Tc = 80°C

#### Application

- AC Switches
- Switched Mode Power Supplies
- Uninterruptible Power Supplies

#### Features

- Fast Trench + Field Stop IGBT3 Technology
  - Low voltage drop
  - Low tail current
  - Switching frequency up to 20 kHz
  - Soft recovery parallel diodes
  - Low diode VF
  - Low leakage current
  - RBSOA and SCSOA rated
- Kelvin emitter for easy drive
  - Very low stray inductance
    - Symmetrical design
    - Lead frames for power connections
  - High level of integration
- Internal thermistor for temperature monitoring

#### Benefits

- Stable temperature behavior
- Very rugged
- Solderable terminals for easy PCB mounting
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Easy paralleling due to positive TC of VCEsat
- Low profile
- RoHS Compliant

### Absolute maximum ratings

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Sy	mbol	Parameter		Max ratings	Unit
V	/ <sub>CES</sub>	Collector - Emitter Breakdown Voltage		1200	V
	I <sub>C</sub>	Continuous Collector Current	$T_C = 25^{\circ}C$	140	
	I <sub>C</sub>	Continuous Collector Current	$T_C = 80^{\circ}C$	100	А
]	I <sub>CM</sub>	Pulsed Collector Current	$T_C = 25^{\circ}C$	200	
V	V <sub>GE</sub>	Gate – Emitter Voltage		±20	V
	P <sub>D</sub>	Maximum Power Dissipation	$T_C = 25^{\circ}C$	480	W
RB	BSOA	Reverse Bias Safe Operating Area	$T_j = 125^{\circ}C$	200A @ 1100V	

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CAUTION: These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com

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### All ratings (a) $T_j = 25^{\circ}C$ unless otherwise specified

### **Electrical Characteristics**

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
I <sub>CES</sub>	Zero Gate Voltage Collector Current	$V_{GE} = 0V, V_{CE} = 1200V$				250	μΑ
V	Collector Emitter Saturation Voltage	, GE 10 ,	$T_j = 25^{\circ}C$	1.4	1.7	2.1	V
V <sub>CE(sat)</sub>			$T_j = 125^{\circ}C$		2.0		v
V <sub>GE(th)</sub>	Gate Threshold Voltage	$V_{GE} = V_{CE}, I_C = 2 \text{ mA}$		5.0	5.8	6.5	V
I <sub>GES</sub>	Gate – Emitter Leakage Current	$V_{GE} = 20V, V_{CE} = 0V$				400	nA

## **Dynamic Characteristics**

Symbol	Characteristic	Test Conditions	Min	Тур	Max	Unit
Cies	Input Capacitance	$V_{GE} = 0V$		7200		
Coes	Output Capacitance	$V_{CE} = 25V$		400		pF
C <sub>res</sub>	Reverse Transfer Capacitance	f = 1MHz		300		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (25°C)		260		
Tr	Rise Time	$V_{GE} = \pm 15 V$		30		ns
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		420		
T <sub>f</sub>	Fall Time	$R_G = 3.9\Omega$		70		
T <sub>d(on)</sub>	Turn-on Delay Time	Inductive Switching (125°C)		290		
Tr	Rise Time	$V_{GE} = \pm 15V$		50		
T <sub>d(off)</sub>	Turn-off Delay Time	$V_{Bus} = 600V$ $I_{C} = 100A$		520		ns
$T_{\rm f}$	Fall Time	$R_G = 3.9\Omega$		90		
Eon	Turn on Energy	$V_{GE} = \pm 15V$ $V_{Bus} = 600V$ $T_j = 125^{\circ}C$		10		mJ
E <sub>off</sub>	Turn off Energy	$\begin{array}{c} I_{\rm C} = 100 A \\ R_{\rm G} = 3.9 \Omega \end{array} \qquad T_{\rm j} = 125^{\circ} {\rm C} \end{array}$		10		111,0

## Reverse diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Тур	Max	Unit
V <sub>RRM</sub>	Maximum Peak Repetitive Reverse Voltage			1200			V
I <sub>RM</sub>	Maximum Reverse Leakage Current	V <sub>R</sub> =1200V	$T_{i} = 25^{\circ}C$ $T_{i} = 125^{\circ}C$			250 500	μΑ
I <sub>F</sub>	DC Forward Current		$Tc = 80^{\circ}C$		100	000	А
V <sub>F</sub>	Diode Forward Voltage	$I_{\rm F} = 100 {\rm A}$ $V_{\rm GE} = 0 {\rm V}$	$T_i = 25^{\circ}C$		1.6	2.1	V
▼ F			$T_{i} = 125^{\circ}C$		1.6		v
t <sub>rr</sub>	Reverse Recovery Time	$T_i = 12$	$T_j = 25^{\circ}C$		170		ns
۹rr			$T_{j} = 125^{\circ}C$		280		115
0	Reverse Recovery Charge	$I_F = 100A$ $V_R = 600V$ $di/dt = 2000A/\mu s$	$T_j = 25^{\circ}C$		9		uС
Q <sub>rr</sub>	Reverse Recovery Charge		$T_{i} = 125^{\circ}C$		18		μC
Б	Reverse Recovery Energy	J	$T_j = 25^{\circ}C$		5		mI
Er			$T_{j} = 125^{\circ}C$		9		mJ

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# APTGT100DU120TG

Temperature sensor NTC (see application note APT0406 on www.microsemi.com for more information).

Symbol	Characteristic	Min	Тур	Max	Unit
R <sub>25</sub>	Resistance @ 25°C		50		kΩ
B 25/85	$T_{25} = 298.15 \text{ K}$		3952		K
-	D				

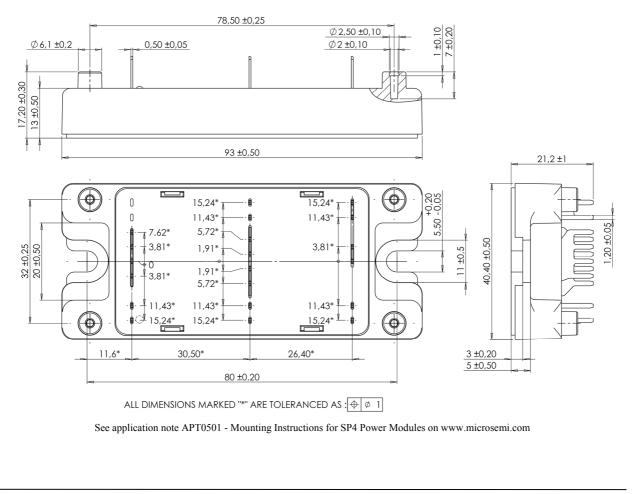
$$R_{T} = \frac{R_{25}}{\exp\left[B_{25/85}\left(\frac{1}{T_{25}} - \frac{1}{T}\right)\right]} \quad \text{T: The} R_{T}: \text{ The}$$

Thermistor temperature : Thermistor value at T

### Thermal and package characteristics

Symbol	Characteristic			Min	Тур	Max	Unit
R <sub>thJC</sub>	Junction to Case Thermal Resistance		IGBT			0.26	°C/W
			Diode			0.48	C/W
VISOL	RMS Isolation Voltage, any terminal to case t =1 min, 50/60Hz			4000			V
TJ	Operating junction temperature range			-40		150	
T <sub>STG</sub>	Storage Temperature Range			-40		125	°C
T <sub>C</sub>	Operating Case Temperature			-40		100	
Torque	Mounting torque	To Heatsink	M5	2.5		4.7	N.m
Wt	Package Weight				160	g	

### SP4 Package outline (dimensions in mm)



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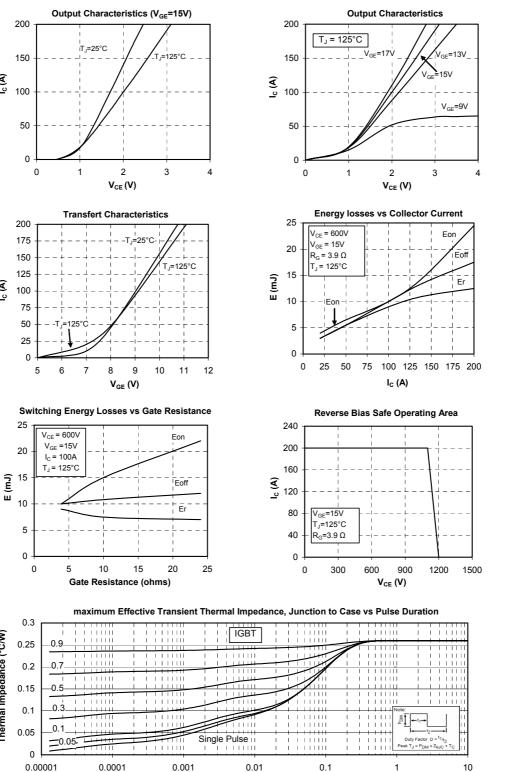


### **Typical Performance Curve**

I<sub>c</sub> (A)

I<sub>c</sub> (A)

Thermal Impedance (°C/W)



rectangular Pulse Duration (Seconds)

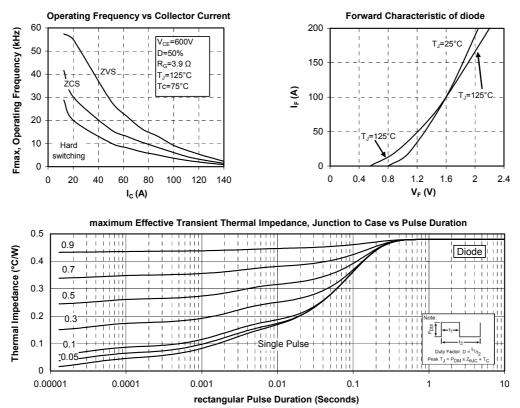
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